TOSHIBA

8 Bit Microcontroller 870C Series

TMP86FS49FG

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CMOS 8-Bit Microcontroller

TMP86FS49FG

Product No.	FLASH	RAM	PACKAGE	Mask MCU
TMP86FS49FG	60K bytes	2K bytes	P-QFP64-1414-0.80A	TMP86CH49/CM49

1.1 Features

- 1. 8-bit single chip microcomputer TLCS-870/C series
 - Instruction execution time :

0.25 µs (at 16 MHz)

122 µs (at 32.768 kHz)

- 132 types & 731 basic instructions
- 2. 24interrupt sources (External : 5 Internal : 19)
- 3. Input / Output ports (56pins)
- 4. Time Base Timer
- 5. Watchdog Timer
- 6. 16-bit timer counter: 1 ch
 - Timer, External trigger, Window, Pulse width measurement, Event counter, PPG(Programmable Pulse Generator) output modes
- 7. 16-bit timer counter : 1ch
 - Timer, Event counter, Window modes
- 8. 8-bit timer counter : 4ch

Timer, Event counter, PWM(Pulse width modulation) output, PDO(Programmable Divider Output) output and PPG(Programmable Pulse Generator) modes

- 9. 8-bit UART: 2ch
- 10. High-Speed SIO: 2ch
- 11. Serial Bus Interface(I²C Bus): 1ch

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12. 10-bit successive approximation type AD converter

Analog inputs: 16ch

- 13. Key On Wake Up : 4ch
- 14. Clock operation

Single clock mode

Dual clock mode

15. Low power consumption operation

STOP mode: Oscillation stops. (Battery/Capacitor back-up.)

SLOW1 mode: Low power consumption operation using low-frequency clock.(High-frequency clock stop.)

SLOW2 mode: Low power consumption operation using low-frequency clock.(High-frequency clock oscillate.)

IDLE0 mode: CPU stops, and only the Time-Based-Timer(TBT) on peripherals operate using high frequency clock. Release by falling edge of the source clock which is set by TBTCR<TBTCK>.

IDLE1 mode: CPU stops and peripherals operate using high frequency clock. Release by interruputs(CPU restarts).

IDLE2 mode: CPU stops and peripherals operate using high and low frequency clock. Release by interruputs. (CPU restarts).

SLEEP0 mode: CPU stops, and only the Time-Based-Timer(TBT) on peripherals operate using low frequency clock.Release by falling edge of the source clock which is set by TBTCR<TBTCK>.

SLEEP1 mode: CPU stops, and peripherals operate using low frequency clock. Release by interruput.(CPU restarts).

SLEEP2 mode: CPU stops and peripherals operate using high and low frequency clock. Release by interruput.

16. Wide operation voltage:

4.5 V~5.5 V at 16.0MHz /32.768 kHz 3.0 V~3.6 V at 8 MHz/32.768 kHz

1.2 Pin Assignment



Figure 1-1 Pin Assignment

1.3 Block Diagram



Figure 1-2 Block Diagram

TOSHIBA

1.4 Pin Names and Functions

Table 1-1Pin Names and Functions (1/3)

Pin Name	Pin Number	Input/Output	Functions
P07	17	IO	PORT07
INT2		I	External interrupt 2 input
Р06	16	IO	PORT06
<u>SCK1</u>		IO	Serial clock input/output 1
P05	15	10	PORT05
SO1		0	Serial data output 1
P04	14	IO	PORT04
SI1		I	Serial data input 1
P03	13	IO	PORT03
INT1		I	External interrupt 1 input
P02	12	IO	PORT02
TxD1		O	UART data output 1
P01	11	10	PORT01
RxD1		1	UART data input 1
BOOT		1	Serial PROM mode control input
P00	10	IO	PORT00
INT0		I	External interrupt 0 input
P17	51	10	PORT17
TC6		1	Timer counter 6 input
PD06/PWM6/PPG6		0	PDO6/PWM6/PPG6 output
P16	50	10	PORT16
TC5		1	Timer counter 5 input
PD05/PWM5		0	PDO5/PWM5 output
P15	49	IO	PORT15
TC2		I	Timer counter 2 input
INT3		I	External interrupt 3 input
P14	48	10	PORT14
TC4		1	Timer counter 4 input
PD04/PWM4/PPG4		0	PDO4/PWM4/PPG4 output
P13	47	10	PORT13
TC3		1	Timer counter 3 input
PD03/PWM3		0	PDO3/PWM3 output
P12	46	IO	PORT12
PPG		I	PPG Output
P11	45	IO	PORT11
DVO		O	Divider output
P10	44	IO	PORT10
TC1		I	Timer counter 1 input
P22	7	10	PORT22
XTOUT		0	Resonator connecting pins(32.768kHz) for inputting external clock
P21	6	IO	PORT21
XTIN		I	Resonator connecting pins(32.768kHz) for inputting external clock
P20	9	IO	PORT20
INT5		I	External interrupt 5 input
STOP		I	STOP mode release signal input

Table 1-1 Pin Names and Functions (2/3)

Pin Name	Pin Number	Input/Output	Functions
P37	64	IO	PORT37
P36	63	IO	PORT36
P35	62	IO	PORT35
P34	61	IO	PORT34
P33	60	IO	PORT33
P32	59	IO	PORT32
P31	58	IO	PORT31
P30	57	IO	PORT30
P47	43	Ю	PORT47
P46 SCK2	42	IO IO	PORT46 Serial clock input/output 2
P45 SO2	41	IO O	PORT45 Serial data output 2
P44 SI2	40	IO I	PORT44 Serial data input 2
P43	39	Ю	PORT43
P42 TxD2	38	IO O	PORT42 UART data output 2
P41 RxD2	37	IO I	PORT41 UART data input 2
P40	36	Ю	PORT40
P54	56	Ю	PORT54
P53	55	Ю	PORT53
P52	54	Ю	PORT52
P51 SDA	53	IO IO	PORT51 I2C bus serial data input/output
P50 SCL	52	IO IO	PORT50 I2C bus serial clock input/output
P67 AIN07 STOP3	27	IO I I	PORT67 AD converter analog input 7 STOP3 input
P66 AIN06 STOP2	26	10 	PORT66 AD converter analog input 6 STOP2 input
P65 AIN05 STOP1	25	IO I I	PORT65 AD converter analog input 5 STOP1 input
P64 AIN04 STOP0	24	IO I I	PORT64 AD converter analog input 4 STOP0 input
P63 AIN03	23	IO I	PORT63 AD converter analog input 3
P62 AIN02	22	IO I	PORT62 AD converter analog input 2

Table 1-1 Pin Names and Functions (3/3)

Pin Name	Pin Number	Input/Output	Functions
P61	21	IO	PORT61
AIN01		I	AD converter analog input 1
P60	20	IO	PORT60
AIN00		I	AD converter analog input 0
P77	35	IO	PORT77
AIN17		I	AD converter analog input 17
P76	34	IO	PORT76
AIN16		I	AD converter analog input 16
P75	33	IO	PORT75
AIN15		I	AD converter analog input 15
P74	32	IO	PORT74
AIN14		I	AD converter analog input 14
P73	31	IO	PORT73
AIN13		I	AD converter analog input 13
P72	30	IO	PORT72
AIN12		I	AD converter analog input 12
P71	29	IO	PORT71
AIN11		I	AD converter analog input 11
P70	28	IO	PORT70
AIN10		I	AD converter analog input 10
XIN	2	I	Resonator connecting pins for high-frequency clock
XOUT	3	0	Resonator connecting pins for high-frequency clock
RESET	8	I	Reset signal input
TEST	4	I	Test pin for out-going test and the Serial PROM mode control pin. Usually fix to low level. Fix to high level when the Serial PROM mode starts.
VAREF	18	I	Analog reference voltage input (High)
AVDD	19	I	AD circuit power supply
VDD	5	I	+5V
VSS	1	I	0(GND)

2. Operational Description

2.1 CPU Core Functions

The CPU core consists of a CPU, a system clock controller, and an interrupt controller.

This section provides a description of the CPU core, the program memory, the data memory, and the reset circuit.

2.1.1 Memory Address Map

The TMP86FS49FG memory consists of 4 blocks: FLASH, RAM, DBR (Data buffer register) and SFR (Special function register). They are all mapped in 64-Kbyte address space. Figure 2-1 shows the TMP86FS49FG memory address map. The general-purpose registers are not assigned to the RAM address space.



Figure 2-1 Memory Address Map

2.1.2 Program Memory (FLASH)

The TMP86FS49FG has a 60K \times 8 bits (Address 1000H to FFFFH) of program memory (FLASH). A program code placed on the internal RAM can be excutable when a certain procedure is executed (See "2.3.2 Address trap reset ").

2.1.3 Data Memory (RAM)

Data memory consists of internal data memory (Internal FLASH or RAM). The TMP86FS49FG has 2Kbyte (Address 0040H to 083FH) of internal RAM. The first 192 bytes (0040H to 00FFH) of the internal RAM are located in the direct area; instructions with shorten operations are available against such an area.

The data memory contents become unstable when the power supply is turned on; therefore, the data memory should be initialized by an initialization routine.

Example :Clears RAM to "00H". (TMP86FS49FG)

	LD	HL, 0040H	; Start address setup
	LD	A, H	; Initial value (00H) setup
	LD	BC, 07FFH	;
SRAMCLR:	LD	(HL), A	
	INC	HL	
	DEC	BC	
	JRS	F, SRAMCLR	

2.2 System Clock Controller

The system clock controller consists of a clock generator, a timing generator, and a standby controller.



Figure 2-2 System Colck Control

2.2.1 Clock Generator

The clock generator generates the basic clock which provides the system clocks supplied to the CPU core and peripheral hardware. It contains two oscillation circuits: One for the high-frequency clock and one for the low-frequency clock. Power consumption can be reduced by switching of the standby controller to low-power operation based on the low-frequency clock.

The high-frequency (fc) clocks and low-frequency (fs) clock can easily be obtained by connecting a resonator between the XIN/XOUT and XTIN/XTOUT pins respectively. Clock input from an external oscillator is also possible. In this case, external clock is applied to XIN/XTIN pin with XOUT/XTOUT pin not connected.



Figure 2-3 Examples of Resonator Connection

Note: The function to monitor the basic clock directly at external is not provided for hardware, however, with disabling all interrupts and watchdog timers, the oscillation frequency can be adjusted by monitoring the pulse which the fixed frequency is outputted to the port by the program. The system to require the adjustment of the oscillation frequency should create the program for the adjustment in advance.

2.2.2 Timing Generator

The timing generator generates the various system clocks supplied to the CPU core and peripheral hardware from the basic clock (fc or fs). The timing generator provides the following functions.

- 1. Generation of main system clock
- 2. Generation of divider output (DVO) pulses
- 3. Generation of source clocks for time base timer
- 4. Generation of source clocks for watchdog timer
- 5. Generation of internal source clocks for timer/counters
- 6. Generation of warm-up clocks for releasing STOP mode

2.2.2.1 Configuration of timing generator

The timing generator consists of a 2-stage prescaler, a 21-stage divider, a main system clock generator, and machine cycle counters.

An input clock to the 7th stage of the divider depends on the operating mode, DV7CK (Bit4 in TBTCR), that is shown in Figure 1-5. As reset and STOP mode started/canceled, the prescaler and the divider are cleared to "0".



Figure 2-4 Configuration of Timing Generator



Note 1: In single clock mode, do not set DV7CK to "1".

Note 2: Do not set "1" on DV7CK while the low-frequency clock is not operated stably.

Note 3: fc: High-frequency clock [Hz], fs: Low-frequency clock [Hz], *: Don't care

Note 4: In SLOW1/2 and SLEEP1/2 modes, the DV7CK setting is ineffective, and fs is input to the 7th stage of the divider.

Note 5: When STOP mode is entered from NORMAL1/2 mode, the DV7CK setting is ineffective during the warm-up period after release of STOP mode, and the 6th stage of the divider is input to the 7th stage during this period.

2.2.2.2 Machine cycle

Instruction execution and peripheral hardware operation are synchronized with the main system clock.

The minimum instruction execution unit is called an "machine cycle". There are a total of 10 different types of instructions for the TLCS-870/C Series: Ranging from 1-cycle instructions which require one machine cycle for execution to 10-cycle instructions which require 10 machine cycles for execution. A machine cycle consists of 4 states (S0 to S3), and each state consists of one main system clock.





2.2.3 Operation Mode Control Circuit

The operation mode control circuit starts and stops the oscillation circuits for the high-frequency and low-frequency clocks, and switches the main system clock. There are two operating modes: Single clock and dual clock. These modes are controlled by the system control registers (SYSCR1 and SYSCR2).

Figure 2-6 shows the operating mode transition diagram.

2.2.3.1 Single-clock mode

Only the oscillation circuit for the high-frequency clock is used, and P21 (XTIN) and P22 (XTOUT) pins are used as input/output ports. The main-system clock is obtained from the high-frequency clock. In the single-clock mode, the machine cycle time is 4/fc [s].

(1) NORMAL1 mode

In this mode, both the CPU core and on-chip peripherals operate using the high-frequency clock.

The TMP86FS49FG is placed in this mode after reset.

(2) IDLE1 mode

In this mode, the internal oscillation circuit remains active. The CPU and the watchdog timer are halted; however on-chip peripherals remain active (Operate using the high-frequency clock).

IDLE1 mode is started by SYSCR2<IDLE>, and IDLE1 mode is released to NORMAL1 mode by an interrupt request from the on-chip peripherals or external interrupt inputs. When the IMF (Interrupt master enable flag) is "1" (Interrupt enable), the execution will resume with the acceptance of the interrupt, and the operation will return to normal after the interrupt service is completed. When the IMF is "0" (Interrupt disable), the execution will resume with the instruction which follows the IDLE1 mode start instruction.

(3) IDLE0 mode

In this mode, all the circuit, except oscillator and the timer-base-timer, stops operation.

This mode is enabled by setting "1" on bit TGHALT on the system control register 2 (SYSCR2).

When IDLE0 mode starts, the CPU stops and the timing generator stops feeding the clock to the peripheral circuits other than TBT. Then, upon detecting the falling edge of the source clock selected with TBTCR<TBTCK>, the timing generator starts feeding the clock to all peripheral circuits.

When returned from IDLE0 mode, the CPU restarts operating, entering NORMAL1 mode back again. IDLE0 mode is entered and returned regardless of how TBTCR<TBTEN> is set. When IMF = "1", EF6 (TBT interrupt individual enable flag) = "1", and TBTCR<TBTEN> = "1", interrupt processing is performed. When IDLE0 mode is entered while TBTCR<TBTEN> = "1", the INTTBT interrupt latch is set after returning to NORMAL1 mode.

2.2.3.2 Dual-clock mode

Both the high-frequency and low-frequency oscillation circuits are used in this mode. P21 (XTIN) and P22 (XTOUT) pins cannot be used as input/output ports. The main system clock is obtained from the high-frequency clock in NORMAL2 and IDLE2 modes, and is obtained from the low-frequency clock in SLOW and SLEEP modes. The machine cycle time is 4/fc [s] in the NORMAL2 and IDLE2 modes, and 4/fs [s] (122 ms at fs = 32.768 kHz) in the SLOW and SLEEP modes.

The TLCS-870/C is placed in the signal-clock mode during reset. To use the dual-clock mode, the low-frequency oscillator should be turned on at the start of a program.

(1) NORMAL2 mode

In this mode, the CPU core operates with the high-frequency clock. On-chip peripherals operate using the high-frequency clock and/or low-frequency clock.

(2) SLOW2 mode

In this mode, the CPU core operates with the low-frequency clock, while both the high-frequency clock and the low-frequency clock are operated. On-chip peripherals are triggered by the low-frequency clock. As the SYSCK on SYSCR2 becomes "0", the hardware changes into NORMAL2 mode. As the XEN on SYSCR2 becomes "0", the hardware changes into SLOW1 mode. Do not clear XTEN to "0" during SLOW2 mode.

(3) SLOW1 mode

This mode can be used to reduce power-consumption by turning off oscillation of the high-frequency clock. The CPU core and on-chip peripherals operate using the low-frequency clock.

Switching back and forth between SLOW1 and SLOW2 modes are performed by XEN bit on the system control register 2 (SYSCR2). In SLOW1 and SLEEP modes, the input clock to the 1st stage of the divider is stopped; output from the 1st to 6th stages is also stopped.

(4) IDLE2 mode

In this mode, the internal oscillation circuit remain active. The CPU and the watchdog timer are halted; however, on-chip peripherals remain active (Operate using the high-frequency clock and/or the low-frequency clock). Starting and releasing of IDLE2 mode are the same as for IDLE1 mode, except that operation returns to NORMAL2 mode.

(5) SLEEP1 mode

In this mode, the internal oscillation circuit of the low-frequency clock remains active. The CPU, the watchdog timer, and the internal oscillation circuit of the high-frequency clock are halted; however, on-chip peripherals remain active (Operate using the low-frequency clock). Starting and releasing of SLEEP mode are the same as for IDLE1 mode, except that operation returns to SLOW mode. In SLOW and SLEEP modes, the input clock to the 1st stage of the divider is stopped; output from the 1st to 6th stages is also stopped.

(6) SLEEP2 mode

The SLEEP2 mode is the idle mode corresponding to the SLOW2 mode. The status under the SLEEP2 mode is same as that under the SLEEP1 mode, except for the oscillation circuit of the high-frequency clock.

(7) SLEEP0 mode

In this mode, all the circuit, except oscillator and the timer-base-timer, stops operation. This mode is enabled by setting "1" on bit TGHALT on the system control register 2 (SYSCR2).

When SLEEP0 mode starts, the CPU stops and the timing generator stops feeding the clock to the peripheral circuits other than TBT. Then, upon detecting the falling edge of the source clock selected with TBTCR<TBTCK>, the timing generator starts feeding the clock to all peripheral circuits.

When returned from SLEEP0 mode, the CPU restarts operating, entering SLOW1 mode back again. SLEEP0 mode is entered and returned regardless of how TBTCR<TBTEN> is set. When IMF = "1", EF6 (TBT interrupt individual enable flag) = "1", and TBTCR<TBTEN> = "1", interrupt processing is performed. When SLEEP0 mode is entered while TBTCR<TBTEN> = "1", the INTTBT interrupt latch is set after returning to SLOW1 mode.

2.2.3.3 STOP mode

In this mode, the internal oscillation circuit is turned off, causing all system operations to be halted. The internal status immediately prior to the halt is held with a lowest power consumption during STOP mode.

STOP mode is started by the system control register 1 (SYSCR1), and STOP mode is released by a inputting (Either level-sensitive or edge-sensitive can be programmably selected) to the $\overline{\text{STOP}}$ pin. After the warm-up period is completed, the execution resumes with the instruction which follows the STOP mode start instruction.



Note 1: NORMAL1 and NORMAL2 modes are generically called NORMAL; SLOW1 and SLOW2 are called SLOW; IDLE0, IDLE1 and IDLE2 are called IDLE; SLEEP0, SLEEP1 and SLEEP2 are called SLEEP. Note 2: The mode is released by falling edge of TBTCR<TBTCK> setting.

Figure 2-6 Operating Mode Transition Diagram

			illator			Other	Machine Cycle	
Opera	ting Mode	High Frequency	Low Frequency	CPU Core	TBT	Peripherals	Time	
	RESET			Reset	Reset	Reset		
	NORMAL1	Oscillation		Operate		Operate	4/fc [s]	
Single clock	IDLE1	Oscillation	Stop		Operate	Operate		
	IDLE0			Halt		Halt	_	
	STOP	Stop			Halt	Tiait		
	NORMAL2			Operate with high frequency			4/fc [s]	
	IDLE2	Oscillation		Halt				
	SLOW2	Oscillation		Operate with low frequency		Operate		
Dual clock	SLEEP2		Oscillation	Halt	Operate		4/fs [s]	
	SLOW1			Operate with low frequency			4/13 [3]	
	SLEEP1	Stop						
	SLEEP0			Halt		Halt		
	STOP		Stop		Halt	riait	_	

System Control Register 1

7 6 5 4 3 2 0 SYSCR1 1 (0038H) OUTEN WUT STOP RELM RETM (Initial value: 0000 00**)

STOP	STOP mode start		core and peripherals remain active core and peripherals are halted (Star	t STOP mode)		
RELM	Release method for STOP mode	•	: Edge-sensitive release : Level-sensitive release			
RETM	Operating mode after STOP mode		: Return to NORMAL1/2 mode : Return to SLOW1 mode			
OUTEN	Port output during STOP mode	•	0: High impedance 1: Output kept			
			Return to NORMAL mode	Return to SLOW mode		
		00	$3 imes 2^{16}$ /fc	3×2^{13} /fs		
WUT	Warm-up time at releasing STOP mode	01	2 ¹⁶ /fc	2 ¹³ /fs		
		10	$3 imes 2^{14}$ /fc	$3 imes 2^6$ /fs		
		11	2 ¹⁴ /fc	2 ⁶ /fs		

Note 1: Always set RETM to "0" when transiting from NORMAL mode to STOP mode. Always set RETM to "1" when transiting from SLOW mode to STOP mode.

Note 2: When STOP mode is released with RESET pin input, a return is made to NORMAL1 regardless of the RETM contents.

Note 3: fc: High-frequency clock [Hz], fs: Low-frequency clock [Hz], *; Don't care

Note 4: Bits 1 and 0 in SYSCR1 are read as undefined data when a read instruction is executed.

- Note 5: As the hardware becomes STOP mode under OUTEN = "0", input value is fixed to "0"; therefore it may cause interrupt request on account of falling edge.
- Note 6: When the key-on wakeup is used, the edge realease can not function according to some conditions. It is recommended to set the level realease (RELM = "1").
- Note 7: Port P20 is used as STOP pin. Therefore, when stop mode is started, OUTEN does not affect to P20, and P20 becomes High-Z mode.
- Note 8: The warmig-up time should be set correctly for using oscillator.

System Control Register 2

SYSCR2	7	6	5	4	3	2	1	0	
(0039H)	XEN	XTEN	SYSCK	IDLE		TGHALT	-		(Initial value: 1000 *0**)

XEN	High-frequency oscillator control	0: Turn off oscillation 1: Turn on oscillation	
XTEN	Low-frequency oscillator control	0: Turn off oscillation 1: Turn on oscillation	
SYSCK	Main system clock select (Write)/main system clock moni- tor (Read)	0: High-frequency clock 1: Low-frequency clock	R/W
IDLE	CPU and watchdog timer control (IDLE1/2 and SLEEP1/2 modes)	0: CPU and watchdog timer remain active 1: CPU and watchdog timer are stopped (Start IDLE1/2 and SLEEP1/2 modes)	
TGHALT	TG control (IDLE0 and SLEEP0 modes)	0: Feeding clock to all peripherals from TG1: Stop feeding clock to peripherals except TBT from TG. (Start IDLE0 and SLEEP0 modes)	

Note 1: A reset is applied if both XEN and XTEN are cleared to "0", XEN is cleared to "0" when SYSCK = "0", or XTEN is cleared to "0" when SYSCK = "1".

Note 2: *: Don't care, TG: Timing generator

Note 3: Bits 3, 1 and 0 in SYSCR2 are always read as undefined value.

Note 4: Do not set IDLE and TGHALT to "1" simultaneously.

- Note 5: Because returning from IDLE0/SLEEP0 to NORMAL1/SLOW1 is executed by the asynchronous internal clock, the period of IDLE0/SLEEP0 mode might be shorter than the period setting by TBTCR<TBTCK>.
- Note 6: When IDLE1/2 or SLEEP1/2 mode is released, IDLE is automatically cleared to "0".
- Note 7: When IDLE0 or SLEEP0 mode is released, TGHALT is automatically cleared to "0".
- Note 8: Before setting TGHALT to "1", be sure to stop peripherals. If peripherals are not stopped, the interrupt latch of peripherals may be set after IDLE0 or SLEEP0 mode is released.

2.2.4 Operating Mode Control

2.2.4.1 STOP mode

STOP mode is controlled by the system control register 1, the STOP pin input. The STOP pin is also used both as a port P20 and an INT5 (external interrupt input 5) pin.

STOP mode is started by setting STOP (Bit7 in SYSCR1) to "1". During STOP mode, the following status is maintained.

- 1. Oscillations are turned off, and all internal operations are halted.
- 2. The data memory, registers, the program status word and port output latches are all held in the status in effect before STOP mode was entered.
- 3. The prescaler and the divider of the timing generator are cleared to "0".
- 4. The program counter holds the address 2 ahead of the instruction (e.g., [SET (SYSCR1).7]) which started STOP mode.

STOP mode includes a level-sensitive mode and an edge-sensitive mode, either of which can be selected with the RELM (Bit6 in SYSCR1).

Note 1: During STOP period (from start of STOP mode to end of warm up), due to changes in the external interrupt pin signal, interrupt latches may be set to "1" and interrupts may be accepted immediately after STOP mode is released. Before starting STOP mode, therefore, disable interrupts. Also, before enabling interrupts after STOP mode is released, clear unnecessary interrupt latches.

(1) Level-sensitive release mode (RELM = "1")

In this mode, STOP mode is released by setting the STOP pin high. This mode is used for capacitor backup when the main power supply is cut off and long term battery backup.

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When the $\overline{\text{STOP}}$ pin input is high, executing an instruction which starts STOP mode will not place in STOP mode but instead will immediately start the release sequence (Warm up). Thus, to start STOP mode in the level-sensitive release mode, it is necessary for the program to first confirm that the $\overline{\text{STOP}}$ pin input is low. The following two methods can be used for confirmation.

- 1. Testing a port P20.
- 2. Using an external interrupt input INT5 (INT5 is a falling edge-sensitive input).

Example 1 :Starting STOP mode from NORMAL mode by testing a port P20.

	LD	(SYSCR1), 01010000B	; Sets up the level-sensitive release mode
SSTOPH:	TEST	(P2PRD). 0	; Wait until the $\overline{\mbox{STOP}}$ pin input goes low level
	JRS	F, SSTOPH	
	DI		; IMF ← 0
	SET	(SYSCR1). 7	; Starts STOP mode

Example 2 :Starting STOP mode from NORMAL mode with an INT5 interrupt.





Figure 2-7 Level-sensitive Release Mode

Note 1: In this case of changing to the level-sensitive mode from the edge-sensitive mode, the release mode is not switched until a rising edge of the STOP pin input is detected.

(2) Edge-sensitive release mode (RELM = "0")

In this mode, STOP mode is released by a rising edge of the $\overline{\text{STOP}}$ pin input. This is used in applications where a relatively short program is executed repeatedly at periodic intervals. This periodic signal (for example, a clock from a low-power consumption oscillator) is input to the $\overline{\text{STOP}}$ pin. In the edge-sensitive release mode, STOP mode is started even when the $\overline{\text{STOP}}$ pin input is high level.

Example :Starting STOP mode from NORMAL mode

DI		; IMF ← 0
LD	(SYSCR1), 10010000B	; Starts after specified to the edge-sensitive release mode



Figure 2-8 Edge-sensitive Release Mode

STOP mode is released by the following sequence.

- 1. In the dual-clock mode, when returning to NORMAL2, both the high-frequency and lowfrequency clock oscillators are turned on; when returning to SLOW1 mode, only the lowfrequency clock oscillator is turned on. In the single-clock mode, only the high-frequency clock oscillator is turned on.
- 2. A warm-up period is inserted to allow oscillation time to stabilize. During warm up, all internal operations remain halted. Four different warm-up times can be selected with the WUT (Bits 2 and 3 in SYSCR1) in accordance with the resonator characteristics.
- 3. When the warm-up time has elapsed, normal operation resumes with the instruction following the STOP mode start instruction. The start is made after the prescaler and the divider of the timing generator are cleared to "0".

	WUT	Warm-up Time [ms]				
v	W01	Return to NORMAL Mode	Return to SLOW Mode			
	00	12.288	750			
	01	4.096	250			
	10	3.072	5.85			
	11	1.024	1.95			

Table 2-1 Warm-up Time Example (at fc = 16.0 MHz, fs = 32.768 kHz)

Note: The warm-up time is obtained by dividing the basic clock by the divider. Therefore, the warm-up time may include a certain amount of error if there is any fluctuation of the oscillation frequency when STOP mode is released. Thus, the warm-up time must be considered as an approximate value.

STOP mode can also be released by inputting low level on the $\overline{\text{RESET}}$ pin, which immediately performs the normal reset operation.

Note: When STOP mode is released with a low hold voltage, the following cautions must be observed. The power supply voltage must be at the operating voltage level before releasing STOP mode. The RESET pin input must also be "H" level, rising together with the power supply voltage. In this case, if an external time constant circuit has been connected, the RESET pin input voltage will increase at a slower pace than the power supply voltage. At this time, there is a danger that a reset may occur if input voltage level of the RESET pin drops below the non-inverting high-level input voltage (Hysteresis input).



2.2.4.2 IDLE1/2 mode and SLEEP1/2 mode

IDLE1/2 and SLEEP1/2 modes are controlled by the system control register 2 (SYSCR2) and maskable interrupts. The following status is maintained during these modes.

- 1. Operation of the CPU and watchdog timer (WDT) is halted. On-chip peripherals continue to operate.
- 2. The data memory, CPU registers, program status word and port output latches are all held in the status in effect before these modes were entered.
- 3. The program counter holds the address 2 ahead of the instruction which starts these modes.





(1) Start the IDLE1/2 and SLEEP1/2 modes

When IDLE1/2 and SLEEP1/2 modes start, set SYSCR2<IDLE> to "1". After IMF is set to "0", set the individual interrupt enable flag (EF) which releases IDLE1/2 and SLEEP1/2.

(2) Release the IDLE1/2 and SLEEP1/2 modes

IDLE1/2 and SLEEP1/2 modes include a normal release mode and an interrupt release mode. These modes are selected by interrupt master enable flag (IMF). After releasing IDLE1/2 and SLEEP1/2 modes, the SYSCR2<IDLE> is automatically cleared to "0" and the operation mode is returned to the mode preceding IDLE1/2 and SLEEP1/2 modes.

IDLE1/2 and SLEEP1/2 modes can also be released by inputting low level on the $\overline{\text{RESET}}$ pin. After releasing reset, the operation mode is started from NORMAL1 mode.

(3) Normal release mode (IMF = "0")

IDLE1/2 and SLEEP1/2 modes are released by any interrupt source enabled by the individual interrupt enable flag (EF). After the interrupt is generated, the program operation is resumed from the instruction following the IDLE1/2 and SLEEP1/2 modes start instruction. Normally, the interrupt latches (IL) of the interrupt source used for releasing must be cleared to "0" by load instructions.

(4) Interrupt release mode (IMF = "1")

IDLE1/2 and SLEEP1/2 modes are released by any interrupt source enabled with the individual interrupt enable flag (EF) and the interrupt processing is started. After the interrupt is processed, the program operation is resumed from the instruction following the instruction, which starts IDLE1/2 and SLEEP1/2 modes.

Note: When a watchdog timer interrupts is generated immediately before IDLE1/2 and SLEEP1/2 mode are started, the watchdog timer interrupt will be processed but IDLE1/2 and SLEEP1/2 mode will not be started.



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2.2.4.3 IDLE0 and SLEEP0 modes (IDLE0, SLEEP0)

IDLE0 and SLEEP0 modes are controlled by the system control register 2 (SYSCR2) and the time base timer control register (TBTCR). The following status is maintained during IDLE0 and SLEEP0 modes.

- 1. Timing generator stops feeding clock to peripherals except TBT.
- 2. The data memory, CPU registers, program status word and port output latches are all held in the status in effect before IDLE0 and SLEEP0 modes were entered.
- 3. The program counter holds the address 2 ahead of the instruction which starts IDLE0 and SLEEP0 modes.

Note: Before starting IDLE0 or SLEEP0 mode, be sure to stop (Disable) peripherals.





(1) Start the IDLE0 and SLEEP0 modes

Stop (Disable) peripherals such as a timer counter.

When IDLE0 and SLEEP0 modes start, set SYSCR2<TGHALT> to "1".

(2) Release the IDLE0 and SLEEP0 modes

IDLE0 and SLEEP0 modes include a normal release mode and an interrupt release mode.

These modes are selected by interrupt master flag (IMF), the individual interrupt enable flag of TBT and TBTCR<TBTEN>.

After releasing IDLE0 and SLEEP0 modes, the SYSCR2<TGHALT> is automatically cleared to "0" and the operation mode is returned to the mode preceding IDLE0 and SLEEP0 modes. Before starting the IDLE0 or SLEEP0 mode, when the TBTCR<TBTEN> is set to "1", INTTBT interrupt latch is set to "1".

IDLE0 and SLEEP0 modes can also be released by inputting low level on the $\overline{\text{RESET}}$ pin. After releasing reset, the operation mode is started from NORMAL1 mode.

Note: IDLE0 and SLEEP0 modes start/release without reference to TBTCR<TBTEN> setting.

(3) Normal release mode (IMF \cdot EF7 \cdot TBTCR<TBTEN> = "0")

IDLE0 and SLEEP0 modes are released by the source clock falling edge, which is setting by the TBTCR<TBTCK> without reference to individual interrupt enable flag (EF). After the falling edge is detected, the program operation is resumed from the instruction following the IDLE0 and SLEEP0 modes start instruction.

(4) Interrupt release mode (IMF · EF7 · TBTCR<TBTEN> = "1")

IDLE0 and SLEEP0 modes are released by the source clock falling edge, which is setting by the TBTCR<TBTCK> at INTTBT interrupt source enabled with the individual interrupt enable flag (EF) and INTTBT interrupt processing is started.

- Note 1: Because returning from IDLE0, SLEEP0 to NORMAL1, SLOW1 is executed by the asynchronous internal clock, the period of IDLE0, SLEEP0 mode might be the shorter than the period setting by TBTCR<TBTCK>.
- Note 2: When a watchdog timer interrupt is generated immediately before IDLE0/SLEEP0 mode is started, the watchdog timer interrupt will be processed but IDLE0/SLEEP0 mode will not be started.





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SLOW mode 2.2.4.4

SLOW mode is controlled by the system control register 2 (SYSCR2).

The following is the methods to switch the mode with the warm-up counter (TC4, TC3).

(1) Switching from NORMAL2 mode to SLOW1 mode

First, set SYSCK (Bit5 in SYSCR2) to switch the main system clock to the low-frequency clock for SLOW2 mode.

Next, clear XEN (Bit7 in SYSCR2) to turn off high-frequency oscillation.

Note: The high-frequency clock can be continued oscillation in order to return to NORMAL2 mode from SLOW mode quickly. Always turn off oscillation of high-frequency clock when switching from SLOW mode to stop mode.

When the low-frequency clock oscillation is unstable, wait until oscillation stabilizes before performing the above operations. The timer/counter 6, 5, 4, 3 (TC6, TC5, TC4, TC3) can conveniently be used to confirm that low-frequency clock oscillation has stabilized.

Example 1 :Switching from NORMAL2 mode to SLOW1 mode.

SET	(SYSCR2). 5	; SYSCR2 <sysck> ← 1 (Switches the main system clock to the low-frequency clock for SLOW2)</sysck>
CLR	(SYSCR2). 7	; SYSCR2 <xen> ← 0 (Turns off high-frequency oscillation)</xen>

Example 2 :Switching to the SLOW1 mode after low-frequency clock has stabilized.

	SET	(SYSCR2). 6	; SYSCR2 <xten> ← 1</xten>
	LD	(TC3CR), 43H	; Sets mode for TC4, TC3 (16-bit TC, fs for source)
	LD	(TC4CR), 05H	
	LDW	(TTREG3), 8000H	; Sets warm-up time (Depend on oscillator accompanied)
	DI		; IMF ← 0
	SET	(EIRH). 1	; Enables INTTC4
	EI		; IMF ← 1
	SET	(TC4CR). 3	; Starts TC4, 3
	:		
PINTTC4:	CLR	(TC4CR). 3	; Stops TC4, 3
	SET	(SYSCR2). 5	; SYSCR2 <sysck> ← 1</sysck>
			(Switches the main system clock to the low-frequency clock)
	CLR	(SYSCR2). 7	; SYSCR2 <xen> ← 0</xen>
			(Turns off high-frequency oscillation)
	RETI		
	:		
VINTTC4:	DW	PINTTC4	; INTTC4 vector table

(2) Switching from SLOW1 mode to NORMAL2 mode

First, set XEN (Bit7 in SYSCR2) to turn on the high-frequency oscillation. When time for stabilization (Warm up) has been taken by the timer/counter 4, 3 (TC4, TC3), clear SYSCK (Bit5 in SYSCR2) to switch the main system clock to the high-frequency clock.

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Note: After SYSCK is cleared to "0", executing the instructions is continued by the low-frequency clock for the period synchronized with low-frequency and high-frequency clocks.

High-frequency clock	www.www
Low-frequency clock	
Main system clock SYSCK	

Note: SLOW mode can also be released by inputting low level on the RESET pin, which immediately performs the reset operation. After reset, TMP86FS49FG are placed in NORMAL1 mode.

Example :Switching from the SLOW1 mode to the NORMAL2 mode (fc = 16 MHz, warm-up time is 4.0 ms).

	SET	(SYSCR2). 7	; SYSCR2 <xen> \leftarrow 1 (Starts high-frequency oscillation)</xen>
	LD	(TC3CR), 63H	; Sets mode for TC4, TC3 (16-bit TC, fc for source)
	LD	(TC4CR), 05H	
	LD	(TTREG4), 0F8H	; Sets warm-up time
	DI		; IMF ← 0
	SET	(EIRH). 1	; Enables INTTC4
	EI		; IMF ← 1
	SET	(TC4CR). 3	; Starts TC4, 3
	:		
PINTTC4:	CLR	(TC4CR). 3	; Stops TC4, 3
	CLR	(SYSCR2). 5	; SYSCR2 <sysck> \leftarrow 0 (Switches the main system clock to the high-frequency clock)</sysck>
	RETI		
	:		
VINTTC4:	DW	PINTTC4	; INTTC4 vector table





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2.3 Reset Circuit

The TMP86FS49FG have four types of reset generation procedures: An external reset input, an address trap reset, a watchdog timer reset and a system clock reset. Table 2-2 shows on-chip hardware initialization by reset action.

The malfunction reset circuit such as watchdog timer reset, address trap reset and system clock reset is not initialized when power is turned on. The $\overline{\text{RESET}}$ pin can reset state at the maximum 24/fc [s] (1.5 µs at 16.0 MHz) when power is turned on.

On-chip Hardware	On-chip Hardware		On-chip Hardware	Initial Value	
Program counter	ounter (PC)				
Stack pointer	(SP)	Not initialized	Prescaler and divider of timing generator	0	
General-purpose registers (W, A, B, C, D, E, H, L, IX, IY)		Not initialized	· · · · · · · · · · · · · · · · · · ·		
Jump status flag	(JF)	Not initialized	Watchdog timer	Enable	
Zero flag	(ZF)	Not initialized			
Carry flag (CF) Half carry flag (HF)		Not initialized		Defecto I/O continuitori	
		Not initialized			
Sign flag	(SF)	Not initialized	Output latches of I/O ports	Refer to I/O port circuitry	
Overflow flag	(VF)	Not initialized			
Interrupt master enable flag	(IMF)	0			
Interrupt individual enable flags	(EF)	0		Refer to each of control	
Interrupt latches	(IL)	0	Control registers	register	
			RAM	Not initialized	

Table 2-2 Initializing Internal Status by Reset Action

2.3.1 External Reset Input

The RESET pin contains a Schmitt trigger (Hysteresis) with an internal pull-up resistor.

When the $\overline{\text{RESET}}$ pin is held at "L" level for at least 3 machine cycles (12/fc [s]) with the power supply voltage within the operating voltage range and oscillation stable, a reset is applied and the internal state is initialized.

When the $\overline{\text{RESET}}$ pin input goes high, the reset operation is released and the program execution starts at the vector address stored at addresses FFFEH to FFFFH.



Figure 2-15 Reset Circuit

2.3.2 Address trap reset

If the CPU should start looping for some cause such as noise and an attempt be made to fetch an instruction from the on-chip RAM (when WDTCR1<ATAS> is set to "1"), DBR or the SFR area, address trap reset will be generated. The reset time is about 8/fc to 24/fc [s] (0.5 to 1.5 μ s at 16.0 MHz).

Note: The operating mode under address trapped is alternative of reset or interrupt. The address trap area is alternative.



Note 1: Address "a" is in the SFR or on-chip RAM (WDTCR1<ATAS> = "1") space. Note 2: During reset release, reset vector "r" is read out, and an instruction at address "r" is fetched and decoded.

Figure 2-16 Address Trap Reset

2.3.3 Watchdog timer reset

Refer to 2.4 "Watchdog Timer".

2.3.4 System clock reset

Clearing both XEN and XTEN (Bits 7 and 6 in SYSCR2) to "0", clearing XEN to "0" when SYSCK = "0", or clearing XTEN to "0" when SYSCK = "1" stops system clock, and causes the microcomputer to deadlock. This can be prevented by automatically generating a reset signal whenever XEN = XTEN = "0", XEN = SYSCK = "0", or XTEN = "0"/SYSCK = "1" is detected to continue the oscillation. The reset time is about 8/ fc to 24/fc [s] (0.5 to 1.5 µs at 16.0 MHz).

22. Electrical Characteristics

22.1 Absolute Maximum Ratings

The absolute maximum ratings are rated values which must not be exceeded during operation, even for an instant. Any one of the ratings must not be exceeded. If any absolute maximum rating is exceeded, a device may break down or its performance may be degraded, causing it to catch fire or explode resulting in injury to the user. Thus, when designing products which include this device, ensure that no absolute maximum rating value will ever be exceeded.

				(VSS = 0 V)
Parameter	Symbol	Pins	Ratings	Unit
Supply voltage	V _{DD}		-0.3 to 6.5	
Input voltage	V _{IN}		-0.3 to V _{DD} + 0.3	V
Output voltage	V _{OUT1}		-0.3 to V _{DD} + 0.3	-
Output current (Per 1 pin)	I _{OUT1}	P0, P1, P4, P6, P7 ports	-1.8	
	I _{OUT2}	P0, P1, P4, P6, P7 ports	3.2	
	I _{OUT3}	P3, P5 ports	30	mA
	ΣI_{OUT1}	P0, P1, P4, P6, P7 ports	60	
Output current (Total)	ΣI_{OUT2}	P3, P5 ports	80	
Power dissipation [Topr = 85 °C]	PD		250	mW
Soldering temperature (time)	Tsld		260 (10 s)	
Storage temperature	Tstg		-55 to 125	°C
Operating temperature	Topr		-40 to 85	1

22.2 Recommended Operating Conditions

The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to.

22.2.1 MCU mode (Flash Programming or erasing)

				(V _S	_S = 0 V, Topr = - ⁻	10 to 40°C)
Parameter	Symbol	Pins	Ratings	Min	Max	Unit
Supply voltage	V _{DD}		NORMAL1, 2 modes	4.5	5.5	
Input high loval	V _{IH1}	Except hysteresis input	V _{DD} ≥ 4.5 V	$V_{DD} imes 0.70$	V _{DD}	
Input high level	V _{IH2}	Hysteresis input	VDD ≥ 4.5 V	$V_{DD} imes 0.75$	v DD	V
	V _{IL1}	Except hysteresis input	V _{DD} ≥ 4.5 V	0	$V_{DD} \times 0.30$	
Input low level	V _{IL2}	Except hysteresis input	V _{DD} ≥ 4.5 V	0	$V_{DD} imes 0.25$	
Clock frequency	fc	XIN, XOUT		1.0	16.0	MHz

22.2.2 MCU mode (Except Flash Programming or erasing)

Parameter	Symbol	Pins	F	Ratings	Min	Max	Unit
			fc = 16 MHz	NORMAL1, 2 modes IDLE0, 1, 2 modes			
Supply voltage (Condition 1)			fs = 32.768 KHz	SLOW1, 2 modes SLEEP0, 1, 2 modes	4.5	5.5	
	V _{DD}		STOP mode				
Supply voltage (Condition 2)	♥ DD		fc = 8 MHz	NORMAL1, 2 modes IDLE0, 1, 2 modes		3.6	
			fs = 32.768 KHz	SLOW1, 2 modes SLEEP0, 1, 2 modes	3.0		v
			STOP mode				•
	V _{IH1}	Except hysteresis input	V _{DD} ≥ 4.5 V		$V_{DD} imes 0.70$		
Input high level	V _{IH2}	Hysteresis input	v _{DD} ≥ 4.3 v		$V_{DD} \times 0.75$		
	V _{IH3}		V _{DD} < 4.5 V		$V_{DD} \times 0.90$		
	V _{IL1}	Except hysteresis input				$V_{DD} \times 0.30$	
Input low level	V _{IL2}	Hysteresis input	$V_{DD} \ge 4.5 V$		0	$V_{DD} imes 0.25$	
	V _{IL3}		V _{DD} < 4.5 V			$V_{DD} imes 0.10$	
	fc	XIN, XOUT	V _{DD} = 3.0 to 3.6 \	′, 4.5 to 5.5V	1.0	8.0	
Clock frequency	fc	XIN, XOUT	V _{DD} = 4.5 to 5.5 \	1	1.0	16.0	MHz
	fs	XTIN, XTOUT	V _{DD} = 3.0 to 3.6 \	′, 4.5 to 5.5V	30.0	34.0	kHz

Note 1: The Supply voltage (V_{DD}) is divided into two different voltage areas. Do not change V_{DD} from Condition 1 to Condition 2 and vice versa while the MCU is operationg. If you wish to use V_{DD} in a continuous range of 3.0V to 5.5V without stopping the MCU, please contact your local Toshiba office.

 $(V_{SS} = 0 V, Topr = -40 \text{ to } 85^{\circ}C)$

22.2.3 Serial PROM mode

(V_{SS} = 0 V, Topr = -10 to 40 $^{\circ}$ C)

Parameter	Symbol	Pins	Condition	Min	Max	Unit
Supply voltage	V _{DD}		NORMAL1, 2 modes	4.5	5.5	
Input high voltage	V _{IH1}	Except hysteresis input	V _{DD} ≥ 4.5 V	$V_{DD} \times 0.70$	V _{DD}	
Input high voltage	V _{IH2}	Hysteresis input	vDD ≃ 1 .0 v	$V_{DD} \times 0.75$	v DD	V
	V _{IL1}	Except hysteresis input	V _{DD} ≥ 4.5 V	0	$V_{DD} \times 0.30$	
Input low voltage	V _{IL2}	Hysteresis input	v DD ≤ 1 .0 v	0	$V_{DD} \times 0.25$	
Clock frequency	fc	XIN, XOUT		2.0	16.0	MHz

22.3 DC Characteristics

Parameter	Symbol	Pins	Cor	Min	Тур.	Max	Unit	
Hysteresis voltage	V _{HS}	Hysteresis input			_	0.9	_	V
	I _{IN1}	TEST						
Input current	I _{IN2}	Sink open drain, tri-state port	$V_{DD} = 5.5 \text{ V}, \text{ V}_{IN} = 8$	5.5 V/0 V	-	-	±2	μA
	I _{IN3}	RESET, STOP	_					
Input resistance	R _{IN}	RESET pull-up			100	220	450	kΩ
	I _{LO1}	Sink open drain port	V _{DD} = 5.5 V, V _{OUT} =	= 5.5 V	-	-	2	
Output leakage current	I _{LO2}	Tri–state port	V _{DD} = 5.5 V, V _{OUT} :	= 5.5 V/0 V	_	-	±2	μA
Output high voltage	V _{OH}	Tri-state port	V _{DD} = 4.5 V, I _{OH} = -	0.7 mA	4.1	-	-	v
Output low voltage	V _{OL}	Except XOUT, P3, P5	V _{DD} = 4.5 V, I _{OL} = 1	V _{DD} = 4.5 V, I _{OL} = 1.6 mA		-	0.4	v
Output low curren	I _{OL}	High current port (P3, P5 Port)	V _{DD} = 4.5 V, V _{OL} = 1.0 V		-	20	-	
Supply current in NORMAL1, 2 modes			V _{DD} = 5.5 V	When a program operates on flash memory	_	12.6	20	
Supply current in IDLE0 mode			V _{IN} = 5.3 V/0.2 V fc = 16 MHz fs = 32.768 kHz		-	6.3	7.5	mA
Supply current in IDLE 1, 2 modes			13 - 32.700 KHZ		-	7.6	10	
Supply current in SLOW1 mode	I _{DD}			When a program operates on flash memory	_	0.9	3	
SLOWTHOde			V _{DD} = 3.0 V V _{IN} = 2.8 V/0.2 V	When a program operates on RAM	-	10	21	
Supply current in SLEEP1 mode			fs = 32.768 kHz		-	4.5	16	
Supply current in SLEEP0 mode					-	3.5	12	μA
Supply current in STOP mode			V _{DD} = 5.5 V V _{IN} = 5.3 V/0.2 V		-	0.5	10	

(V_{SS} = 0 V, Topr = -40 to 85 $^{\circ}$ C)

Note 1: Typical values show those at Topr = 25°C and V_{DD} = 5 V.

Note 2: Input current (I_{IN1} , I_{IN3}): The current through pull-up or pull-down resistor is not included.

Note 3: I_{DD} does not include $I_{\text{REF}}.$

Note 4: The supply currents of SLOW2 and SLEEP2 modes are equivalent to those of IDLE1 and IDLE2 modes.

22.4 AD Characteristics

(V_{SS} = 0.0 V, 4.5 V \leq V_{DD} $\,\leq\,$ 5.5 V, Topr = -40 to 85 °C)

				88	-	
Paramete	Symbol	Condition	Min	Тур.	Max	Unit
Analog reference voltage	V _{AREF}		A _{VDD} - 1.0	-	A _{VDD}	
Power supply voltage of analog control circuit	A _{VDD}			V _{DD}		v
Analog reference voltage range (Note 4)	ΔV_{AREF}		3.5	-	-	
Analog input voltage	V _{AIN}		V _{SS}	-	V _{AREF}	
Power supply current of analog reference voltage	I _{REF}	$V_{DD} = A_{VDD} = V_{AREF} = 5.5 V$ $V_{SS} = A_{VSS} = 0.0 V$	-	0.6	1.0	mA
Non linearity error			-	-	±2	
Zero point error		$V_{DD} = A_{VDD} = 5.0 V,$ $V_{SS} = A_{VSS} = 0.0 V$	-	-	±2	LSB
Full scale error		$V_{\text{AREF}} = 5.0 \text{ V}$	-	-	±2	130
Total error			-	-	±2	

(V_{SS} = 0 V, 3.0 V \leq V_{DD} \leq 3.6 V, Topr = -40 to 85°C)

Parameter	Symbol	Condition	Min	Тур.	Max	Unit
Analog reference voltage	V _{AREF}		A _{VDD} - 1.0	-	A _{VDD}	
Power supply voltage of analog control circuit	A _{VDD}			V _{DD}		v
Analog reference voltage range (Note 4)	ΔV_{AREF}		2.5	-	-	
Analog input voltage	V _{AIN}		V _{SS}	-	V _{AREF}	1
Power supply current of analog reference voltage	I _{REF}	$V_{DD} = A_{VDD} = V_{AREF} = 3.6 V$ $V_{SS} = A_{VSS} = 0.0 V$	_	0.5	0.8	mA
Non linearity error			-	-	±2	
Zero point error		$V_{DD} = A_{VDD} = 3.0 V$ $V_{SS} = A_{VSS} = 0.0 V$	-	-	±2	LSB
Full scale error		$V_{\text{SS}} = A_{\text{VSS}} = 0.0 \text{ V}$ $V_{\text{AREF}} = 3.0 \text{ V}$	-	-	±2	LOD
Total error		· · · ·	-	-	±2	

Note 1: The total error includes all errors except a quanitization error, and is defined as a maximum deviation from the ideal conversion line.

Note 2: Conversion time is defferent in recommended value by power supply voltage.

Note 3: The voltage to be input on the AIN input pin must not exceed the range between V_{AREF} and V_{SS} . If a voltage outside this range is input, conversion values will become unstable and conversion values of other channels will also be affected.

Note 4: Analog reference voltage range: $\Delta V_{AREF} = V_{AREF} - V_{SS}$

Note 5: When AD converter is not used, fix the AVDD and VAREF pin on the $\rm V_{\rm DD}$ level.

Machine cycle time

Low-level clock pulse width

High-level clock pulse width

Low-level clock pulse width

μS

22.5 AC Characteristics

$(V_{SS} = 0 \text{ V}, V_{DD} = 4.5 \text{ V} \text{ to } 5.5 \text{ V}, \text{ Topr} = -40 \text{ to } 85^{\circ}\text{C})$ Parameter Symbol Condition Min Тур. Max Unit NORMAL1, 2 modes 0.25 4 _ IDLE0, 1, 2 modes tcy μs SLOW1, 2 modes 117.6 133.3 _ SLEEP0, 1, 2 modes High-level clock pulse width t_{WCH} For external clock operation (XIN input) 31.25 ns _ fc = 16 MHz

 $(V_{SS} = 0 \text{ V}, V_{DD} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}, \text{ Topr} = -40 \text{ to } 85^{\circ}\text{C})$

15.26

			(155 0 1, 10			
Paramete	Symbol	Condition	Min	Тур.	Max	Unit
Machine cycle time	t _{cy}	NORMAL1, 2 modes	0.5	-	4	- μ s
		IDLE0, 1, 2 modes				
		SLOW1, 2 modes	117.6	-	133.3	
		SLEEP0, 1, 2 modes				
High-level clock pulse width	t _{WCH}	For external clock operation (XIN input) fc = 8 MHz	-	62.5	-	ns
Low-level clock pulse width	t _{WCL}					
High-level clock pulse width	t _{WSH}	For external clock operation (XTIN input) fs = 32.768 kHz	-	15.26	-	μs
Low-level clock pulse width	t _{WSL}					

For external clock operation (XTIN input)

fs = 32.768 kHz

22.6 Flash Characteristics

22.6.1 Write/Retention Characteristics

t_{WCL}

t_{WSH}

t_{WSL}

 $(V_{SS} = 0 V)$

				,	, 00
Paramete	Condition	Min	Тур.	Max.	Unit
Number of guaranteed writes to flash memory	V _{SS} = 0 V, Topr = -10 to 40°C	-	-	100	Times

22.7 Recommended Oscillating Conditions



- Note 1: To ensure stable oscillation, the resonator position, load capacitance, etc. must be appropriate. Because these factors are greatly affected by board patterns, please be sure to evaluate operation on the board on which the device will actually be mounted.
- Note 2: The product numbers and specifications of the resonators by Murata Manufacturing Co., Ltd. are subject to change. For up-to-date information, please refer to the following URL: http://www.murata.co.jp/search/index.html

22.8 Handling Precaution

- The solderability test conditions for lead-free products (indicated by the suffix G in product name) are shown below.
 - When using the Sn-63Pb solder bath Solder bath temperature = 230 °C Dipping time = 5 seconds Number of times = once R-type flux used
 - 2. When using the Sn-3.0Ag-0.5Cu solder bath

Solder bath temperature = 245 °C Dipping time = 5 seconds Number of times = once

R-type flux used

Note: The pass criteron of the above test is as follows:

Solderability rate until forming \ge 95 %

- When using the device (oscillator) in places exposed to high electric fields such as cathode-ray tubes, we recommend electrically shielding the package in order to maintain normal operating condition.